


<b>Search Notes</b>  	<b>Application/Control No.</b>  10623569	<b>Applicant(s)/Patent Under Reexamination</b>  MIYANO ET AL.
	<b>Examiner</b>  Anish Desai	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search using EAST	3/6/2008	APD
428/343,354 (USPAT, USPGPUB and USOCR text search only)	3/12/2008	APD
Text search (USPAT, USPGPUB, USOCR)	3/12/2008	APD
Allowance consultation with SPE	03/04/08	APD
Interference search (see interference search history printout)	03/12/08	APD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
428	343,354	03/12/08	APD